

<b>Notice of References Cited</b>	Application/Control No. 10/607,207	Applicant(s)/Patent Under Reexamination YOON, SUNGHOE	
	Examiner (Nancy) Thanh-Nhan P. Nguyen	Art Unit 2871	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2001/0026335	10-2001	Moon, Jong-Weon	349/63
	B	US-6,061,108	05-2000	Anderson et al.	349/98
	C	US-2001/0055083	12-2001	Jiang et al.	349/115
	D	US-2002/0163616	11-2002	Jones et al.	349/187
	E	US-2003/0147016	08-2003	Lin et al.	349/12
	F	US-5,805,250	09-1998	Hatano et al.	349/96
	G	US-6,320,629	11-2001	Hatano et al.	349/15
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.